

# Search Notes



Application/Control No.

10/648,967

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under Reexamination

DELANEY ET AL.

Art Unit

2187

## SEARCHED

Class	Subclass	Date	Examiner
711	202	Text search see EAST pr	
	170		
updated above using Text search. 12/28/05 Hw			

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST search his. is attached.	9/19/05 Hw	
NPL search using terms similar to EAST search		
Inventorship search		
updated EAST search.	12/28/05 Hw	